Search Notes

Applicat	ion/Co	ntrol I	٧o.

10/601,334 Examiner

Richale L. Haney

A	pplicant(s)/Patent	under
R	eexamination	

DIAMOND ET AL.

Art Unit

3765

	SEARCHED		
Class	Subclass	Date	Examiner
	-		
			

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
	•		

(INCLUDING SE	CH NOTES ARCH STRATEG	Υ)
	DATE	EXMR
search updated	3/20/2006	RLH